FINAL PRESENTATION DAYS - 3-4-5 February 2015 — ESA/ESTEC



Title:	"High Reliability MEMS Redundancy Switch"		
Contract type	TRP	Budget (K€)	870 k€
Company (-ies) (including country)	CEA-LETI (FR); NKUA (GR), TAS (FR), CNRS-LAAS (FR)		
Team (name of the participant in the project)	CEA: B. Reig, C. Dieppedale, H. Sibuet, F. Souchon NKUA: G. Papaioannou, M. Koutsoureli TAS: B. Espana, O. Vendier, A. Renel CNRS-LAAS: F. Coccetti, N. Torres-Matabosch		
(*) Speaker (s)	G. Papaioannou	Email	gpapaioan@phys.uoa.gr
Short Speaker Information (experience and involvement in this project)	Prof. G. Papaioannou is with the Solid State Physics Section of Athens University. The research activities of his group are focussed on reliability of III-V and Si based semiconductor devices. During last decade a major effort is paid on the understanding of mechanisms of main reliability failure mode in RF-MEMS capacitive switches that is the dielectric charging arising from contacted or field emission charge injection and field induced polarization.		
Summary of the activity (maximum 400 words)	injection and field induced polarization. The scope of the activity was to develop advanced RF-MEMS switches for DC to 60 GHz applications that require high reliability. Main performances specified in the frame of the project are: • SPDT with high isolation (50dB) and low losses (0,5dB) in Ku-band • Long term reliability: lifetime 15 years with 1000 actuation max In the project the key parameters for enhanced reliability were studied and a fabrication process of a switch was developed. The technology is based on a dielectric-less electrostatic actuation in order to prevent from failure due to dielectric charging. Ruthenium and gold metallisation were compared in order to obtain enhanced contact reliability. RF perfomances were measured, lifetime was evaluated, thermal behavior assessed. Main failure mechanisms coming from contact degradation, charging effect, creep, field emission were discussed.		

^(*) The speaker needs to do the registration through the website